

**Search Notes**

Application/Control No.

09/773,387

Examiner

J. Derek Rутten

Applicant(s)/Patent under  
Reexamination

SWAINE ET AL.

Art Unit

2192

**SEARCHED**

Class	Subclass	Date	Examiner
717	128	3/9/2006	JDR
714	45	3/9/2006	JDR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
717	128	3/9/2006	JDR
714	45	3/9/2006	JDR

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	3/8/2006	JDR
IEEE - ieexplore.ieee.org Google - www.google.com	3/8/2006	JDR
Tuan Dam (consulted re. allowable subject matter)	3/8/2006	JDR
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	3/9/2006	JDR
ACM - portal.acm.org Google - www.google.com	3/9/2006	JDR
Will Grant (consulted re. 101)	3/16/2006	JDR